

<b>Notice of References Cited</b>	Application/Control No. 10/508,404		Applicant(s)/Patent Under Reexamination SHIMIZU ET AL.	
	Examiner James F. Hook		Art Unit 3754	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0185189	12-2002	Tadokoro, Shinichi	138/156
*	B	US-2,930,007	03-1960	Anderson; et. al.	333/241
*	C	US-4,667,702	05-1987	Roth, James E.	138/162
*	D	US-4,877,224	10-1989	Watts, James L.	267/140
*	E	US-4,951,716	08-1990	Tsunoda et al.	138/162
*	F	US-5,126,507	06-1992	Kirma, Safa	174/2
*	G	US-5,300,732	04-1994	Wambeke et al.	174/92
*	H	US-5,566,722	10-1996	Bartholomew, Donald D.	138/166
*	I	US-6,034,329	03-2000	Kawamura, Shigeto	174/102R
*	J	US-6,078,009	06-2000	Kawamura, Shigeto	174/102R
*	K	US-6,079,451	06-2000	Hegler, Ralph Peter	138/121
*	L	US-7,307,217	12-2007	Daito, Koji	174/72A
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
	W	
	X	

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